

Product Change Notification / ALAN-20ESKQ801

Troduct Change Nothication / A	LAN-20LSK	4001			
Date:					
12-Oct-2022					
Product Category:					
8-bit Microcontrollers					
PCN Type:					
Manufacturing Change					
Notification Subject:					
		as an additional test location for selected available in 32L VQFN (5x5x0.9mm) package.			
Affected CPNs:					
ALAN-20ESKQ801_Affected_CPN_1 ALAN-20ESKQ801_Affected_CPN_1	1				
Notification Text:					
PCN Status:Final Notification					
PCN Type:Manufacturing Change					
•		files found in the Affected CPNs section. entical files in two formats (.pdf and .xls)			
Description of Change: Qualification of MPHL as an additional test location for selected ATMEGA88PB and ATMEGA48PB device families available in 32L VQFN (5x5x0.9mm) package.					
Pre and Post Change Summary:					
Pr	e Change	Post Change			

Test Location	ASE Test (ASE9)	ASE Test (ASE9)	Microchip Technology Operations Corporation (MPHL)		
Reel BQM	6000	6000	6000		
Reel Pin 1 Orientation	Quadrant 2	Quadrant 2	Quadrant 2		
Carrier Tape	No change. S	ee pre and post chang	e for comparison.		
Cover Tape	No change. S	ee pre and post chang	e for comparison.		
Plastic Reel	With minor dimensional change. See pre and post change for comparison.				
Moisture Barrier Bag	With minor dimensional change. See pre and post change for comparison.				
Вох	With minor dime	nsional change. See pr comparison.	e and post change for		
Tray BQM	490	490	490		
Tray Pin 1 Orientation	Near Chamfer	Near Chamfer	Near Chamfer		
Tray Bundling	No change. See pre and post change for comparison.				
Moisture Shielding Bag	See pre and post change for comparison.				
Inner Box	With minor dimensional change. See pre and post change for comparison.				

Impacts to Data Sheet:None

Change ImpactNone

Reason for Change:To improve productivity by qualifying MPHL as an additional test location.

Change Implementation Status:In Progress

Estimated First Ship Date:November 14, 2022 (date code: 2247)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	September 2022				October 2022			November 2022						
Workweek	3 6	3 7	3 8	3 9	4 0	4 1	4 2	4 3	4 4	4 5	4 6	4 7	4 8	4 9
Initial PCN Issue Date				Х										

Qual Report Availability				Χ				
Final PCN Issue Date				Χ				
Estimated Implementation Date							Χ	

Method to Identify Change: Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:September 22, 2022: Issued initial notification.

October 12, 2022: Issued final notification. Attached the Qualification Report. Added Cover tape information in the pre and post change table and comparison file. Provided estimated first ship date to be on November 14, 2022.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN_ALAN-20ESKQ801_Pre and Post_Change_Summary.pdf PCN_ALAN-20ESKQ801_Qual_Report.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN</u> home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

ALAN-20ESKQ801 - CCB 3397.006 Final Notice: Qualification of MPHL as an additional test location for selected ATMEGA88PB and ATMEGA48PB device families available in 32L VQFN (5x5x0.9mm) package.

Affected Catalog Part Numbers(CPN)

ATMEGA88PB-MU

ATMEGA48PB-MU

ATMEGA88PB-MN

ATMEGA48PB-MN

ATMEGA88PB-MNR

ATMEGA48PB-MNR

ATMEGA88PB-MUR

ATMEGA48PB-MUR

CCB 3397.006 Pre and Post Change Summary PCN# ALAN-20ESKQ801



A Leading Provider of Smart, Connected and Secure Embedded Control Solutions



Tape and Reel

Plant	BQM	Pin1	
ASE9	6000 per reel	Quadrant 2	
MPHL	6000 per reel	Quadrant 2	



Carrier Tape

Plant	Width	Pitch	Α0	В0	КО
ASE9	12 mm	8 mm	5.25 mm	5.25 mm	1.1 mm
MPHL	12 mm	8 mm	5.25 mm	5.25 mm	1.1 mm

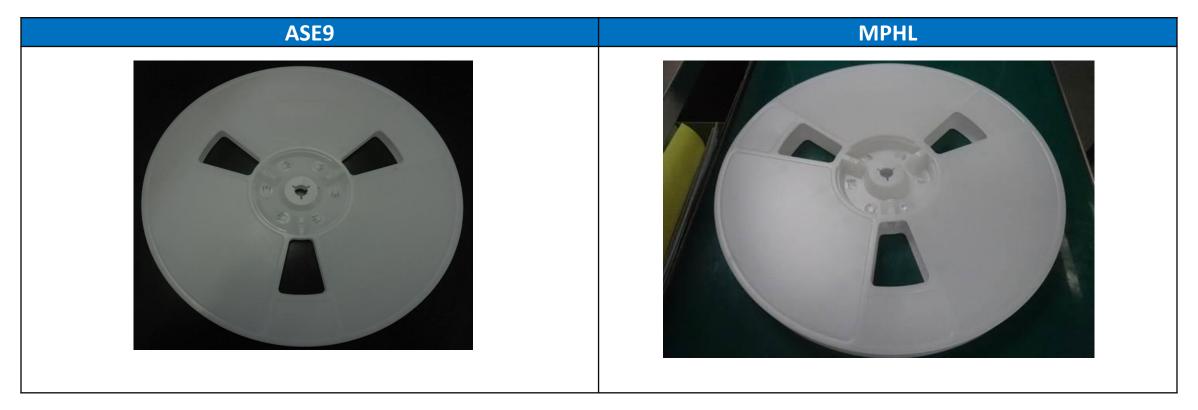


Cover Tape

Plant	Width	Color	Sealing Process
ASE9	9.2 mm	Clear White	Heat Seal
MPHL	9.3 mm	Clear White	Pressure Seal



Plastic Reel



Plant	Color	Diameter	Hub Dia	W1	W2
ASE9	White	330	102 mm	4.4 mm - 8.4 mm	7.1 mm - 11.1 mm
MPHL	White	330	100 mm +/- 1.5	12.4 mm	18.4 mm



TNR - Moisture Barrier Bag



Plant	Length	Width
ASE9	495 mm	430 mm
MPHL	457 mm	406 mm



TNR - Box



Plant	Length	Width	Height
ASE9	370 mm	351 mm	53 mm
MPHL	375 mm	352 mm	53 mm

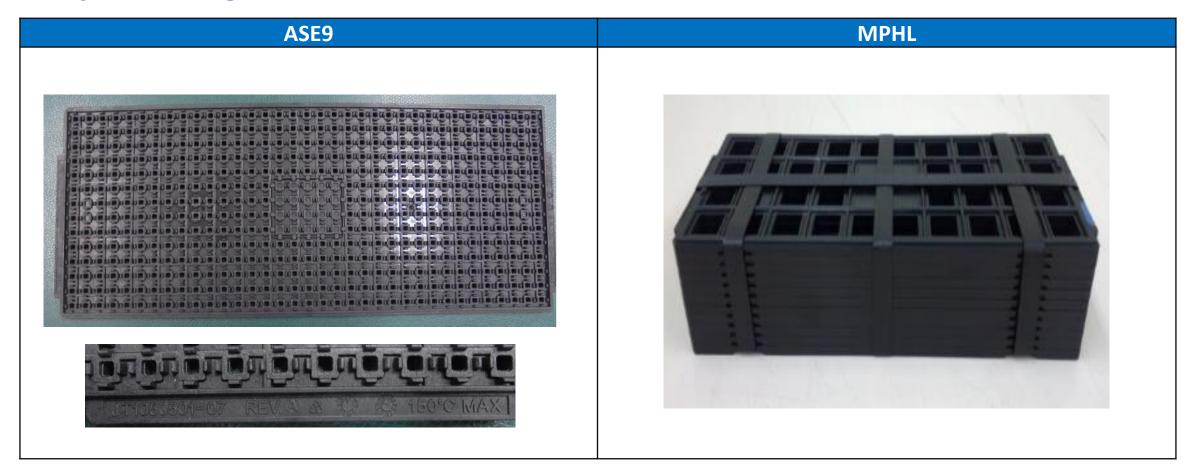


Tray

Plant	BQM	Pin1
ASE9	490 per Tray	Near Tray Chamfer
MPHL	490 per Tray	Near Tray Chamfer



Tray Bundling



Plant	Tray Quantity
ASE9	10 + 1 cover tray
MPHL	10 + 1 cover tray



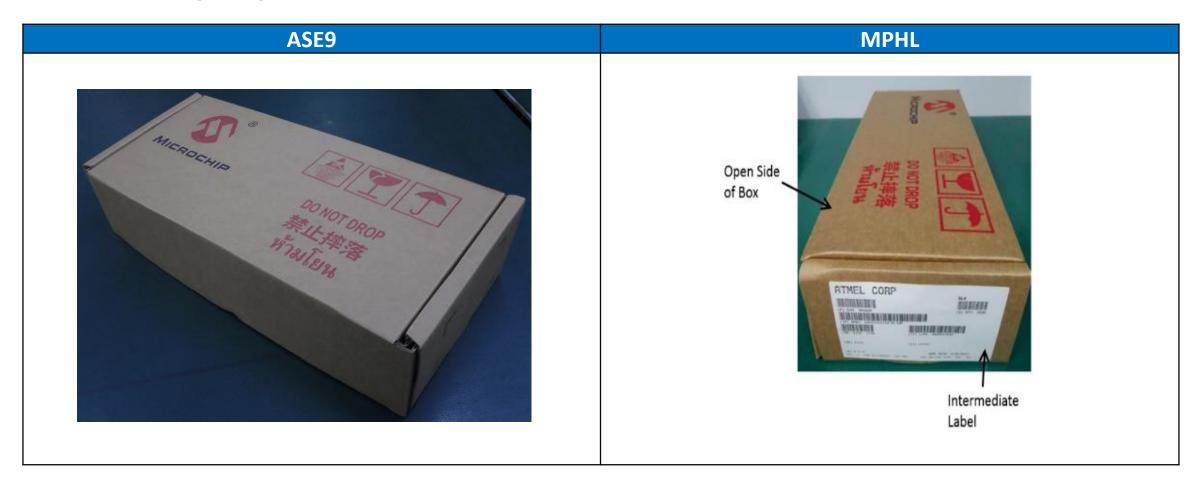
TRAY - Moisture Shielding Bag



Plant	Shielding Bag
ASE9	Static Shielding Bag (SSB)
MPHL	Static Shielding Bag (SSB)



TRAY - Inner Box



Plant	Length	Width	Height
ASE9	371.5 mm	162 mm	88 mm
MPHL	371 mm	162 mm	88 mm





QUALIFICATION PLAN SUMMARY

PCN# ALAN-20ESKQ801

Date: October 7, 2022

Qualification of MPHL as an additional test location for selected ATMEGA88PB and ATMEGA48PB device families available in 32L VQFN (5x5x0.9mm) package.

Purpose: Qualification of MPHL as an additional test location for selected ATMEGA88PB

and ATMEGA48PB device families available in 32L VQFN (5x5x0.9mm)

package.

CCB No.: 3397.006

Test / Evaluation	Test Conditions / Parameters	Result
Datalog/Bin Comparison	 Compare test numbers, test names, test sequence bin assignments & pass/fail results Accept if all match or justify the differences 	Pass
Site by Site verification	Verifies the channel map has the correct site assignments and tester/handler communications work correctly	Pass
Correlation lot report	 Yield at each step and reject analysis between systems. 5K units are tested for each program conversion we perform. Accept on yield match within 0.1% 	Pass
Unit to unit parametric correlation	A full assembly strip characterized on both systems and graphed vs each other & the data sheet limits	Pass
Test stability	50 loop test performed with no datalog delaysAccept on 0 fails	Pass
Parametric test stability verification	- Use Real Time Statistics software	Pass